



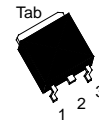
H50N03J

N-Channel Enhancement-Mode MOSFET (25V, 50A)

Features

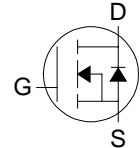
- $R_{DS(on)}=6m\Omega@V_{GS}=10V, I_D=30A$
- $R_{DS(on)}=9m\Omega@V_{GS}=4.5V, I_D=30A$
- Advanced trench process technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for DC/DC Converters and Motor Drivers
- Fully Characterized Avalanche Voltage and Current
- Improved Shoot-Through FOM

H50N03J Pin Assignment



3-Lead Plastic **TO-252**
 Package Code: J
 Pin 1: Gate
 Pin 2 & Tab: Drain
 Pin 3: Source

Internal Schematic Diagram



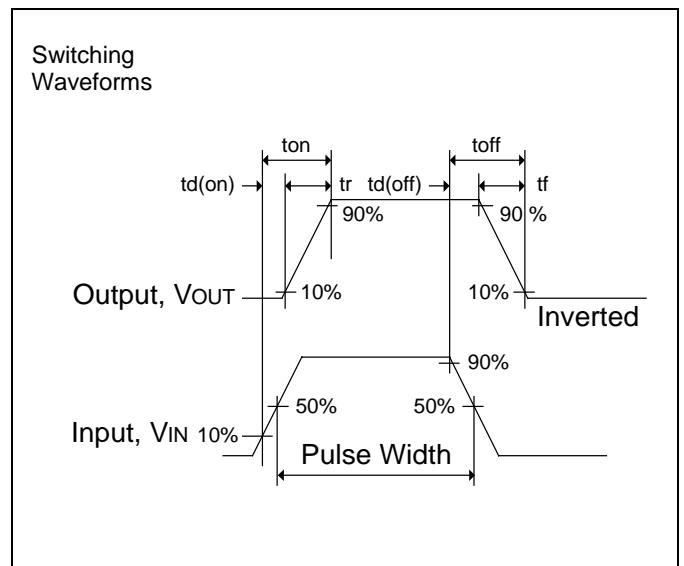
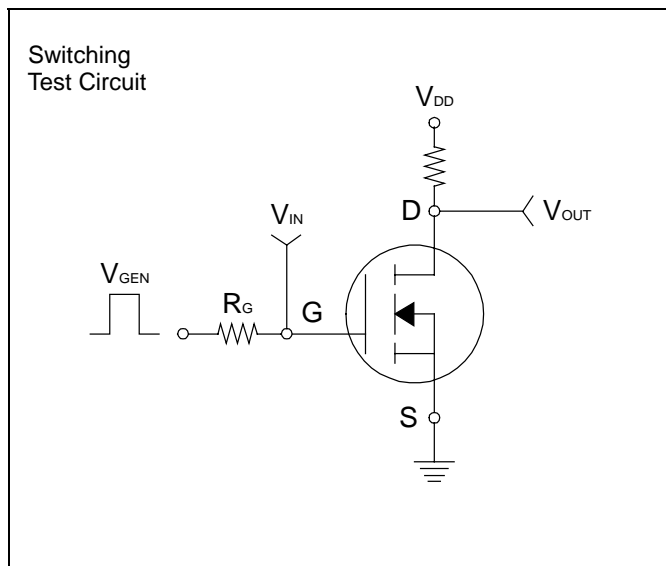
Maximum Ratings & Thermal Characteristics

($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Units	
Drain-Source Voltage	V_{DS}	25	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current	I_D	50	A	
Pulsed Drain Current ^{*1}	I_{DM}	350	A	
Maximum Power Dissipation	P_D	$T_A=25^\circ\text{C}$	70	W
		$T_A=75^\circ\text{C}$	42	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$	
Avalanche Energy with Single Pulse $I_D=50A, V_{DD}=25V, L=0.1mH$	E_{AS}	300	mJ	
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	1.8	$^\circ\text{C/W}$	
Junction-to-Ambient Thermal Resistance(PCB mounted) ^{*2}	$R_{\theta JA}$	40	$^\circ\text{C/W}$	

*1: Maximum DC current limited by the package.

*2: 1-in² 2oz Cu PCB board





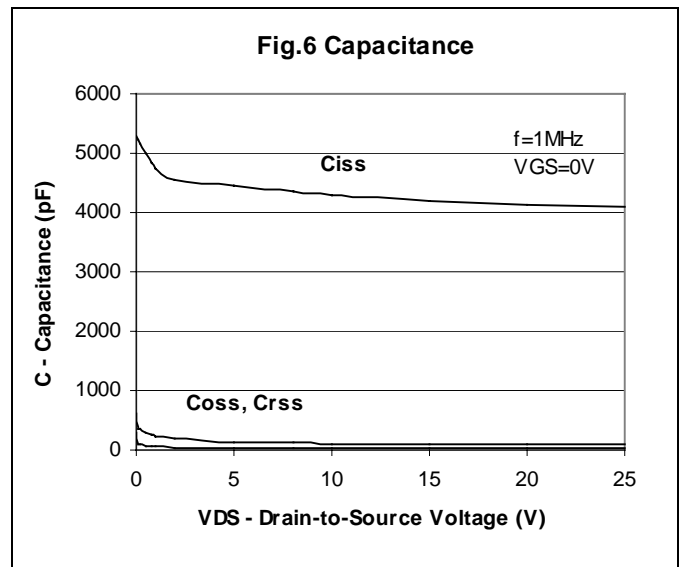
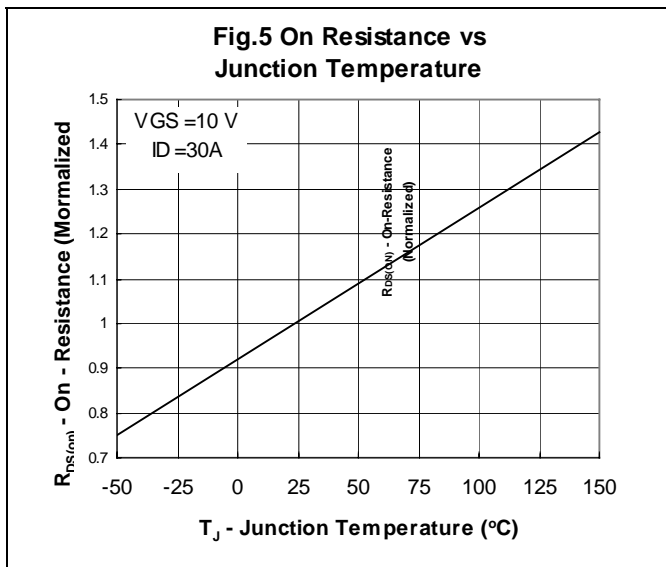
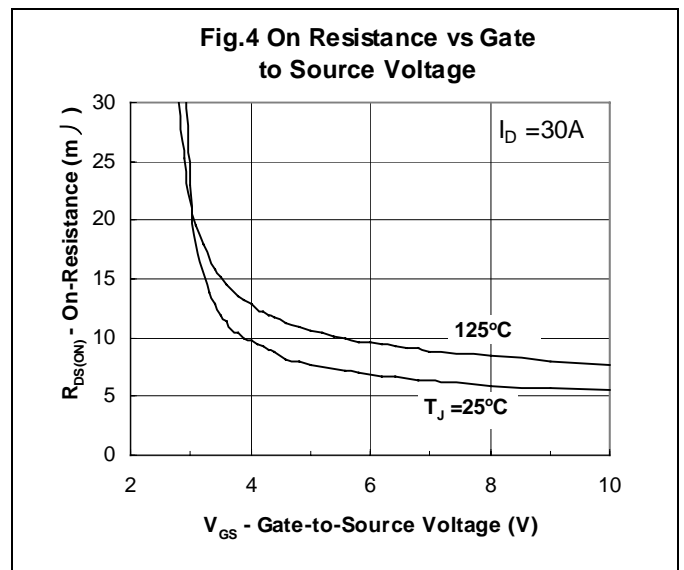
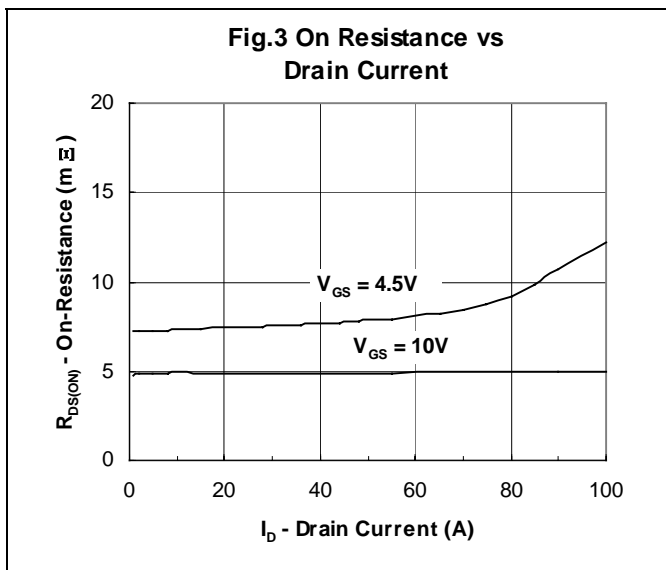
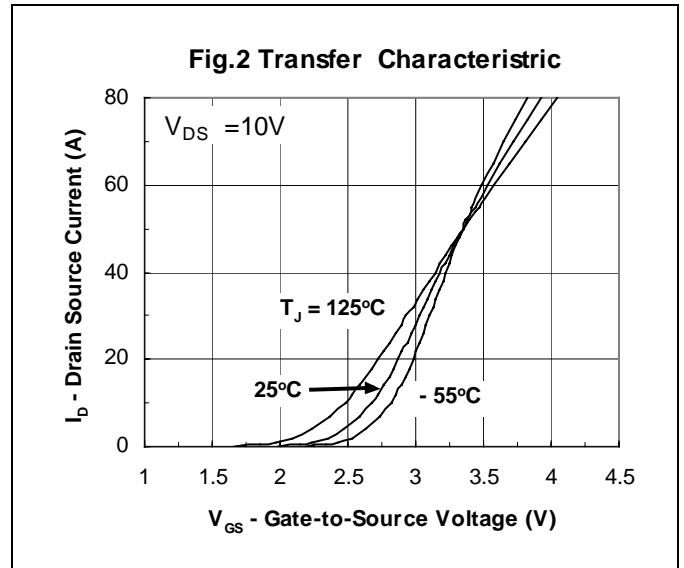
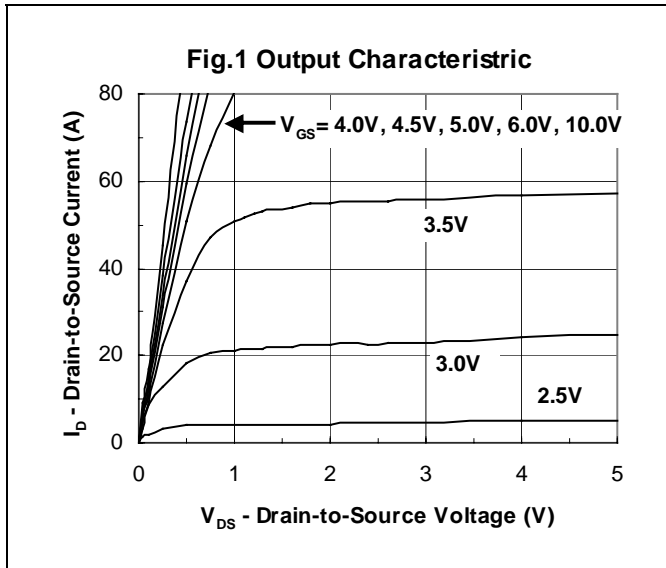
Electrical Characteristics

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	25	-	-	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=30A$	-	7.5	9	m Ω
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=30A$	-	4.5	6	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.3	1.9	3	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=25V, V_{GS}=0V$	-	-	1	μA
Gate Body Leakage	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Gate Resistance	R_g	$V_{DS}=0V, V_{GS}=1V$ at 1MHz	-	3	-	Ω
Forward Transconductance	g_{fs}	$V_{DS}=15V, I_D=15A$	-	50	-	S
Dynamic						
Total Gate Charge	Q_g	$V_{DS}=15V, I_D=20A, V_{GS}=5V$	-	16.8	-	nC
Gate-Source Charge	Q_{gs}		-	6.08	-	
Gate-Drain Charge	Q_{gd}		-	4.93	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=15V, R_L=15\Omega, I_D=1A$ $V_{GEN}=10V, R_G=6\Omega$	-	15.3	-	nS
Turn-On Rise Time	t_r		-	4	-	
Turn-Off Delay Time	$t_{d(off)}$		-	45.27	-	
Turn-Off Fall Time	t_f		-	7.6	-	
Input Capacitance	C_{iss}	$V_{DS}=15V, V_{GS}=0V, f=1MHz$	-	2325.9	-	pF
Output Capacitance	C_{oss}		-	330.55	-	
Reverse Transfer Capacitance	C_{rss}		-	173.91	-	
Source-Drain Diode						
Max. Diode Forward Current	I_S		-	-	50	A
Diode Forward Voltage	V_{SD}	$I_S=20A, V_{GS}=0V$	-	0.85	1.3	V

NOTE: Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



Characteristics Curve





TO-252 Dimension

3-Lead TO-252 Plastic
Surface Mount Package
HSMC Package Code: J

Marking:

Pb Free Mark
 Pb-Free: "●" (Note)
 Normal: None

Date Code Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Gate 2.Drain 3.Source

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

DIM	Min.	Max.
A	6.35	6.80
C	4.80	5.50
F	1.30	1.70
G	5.40	6.25
H	2.20	3.00
L	0.40	0.90
M	2.20	2.40
N	0.90	1.50
a1	0.40	0.65
a2	-	*2.30
a5	0.65	1.05

*: Typical, Unit: mm

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DIM	Min.	Max.
A	6.40	6.80
B	-	6.00
C	5.04	5.64
D	-	*4.34
E	0.40	0.80
F	0.50	0.90
G	5.90	6.30
H	2.50	2.90
I	9.20	9.80
J	0.60	1.00
K	-	0.96
L	0.66	0.86
M	2.20	2.40
N	0.70	1.10
O	0.82	1.22
a1	0.40	0.60
a2	2.10	2.50
y1	-	5°
y2	-	3°

*: Typical, Unit: mm

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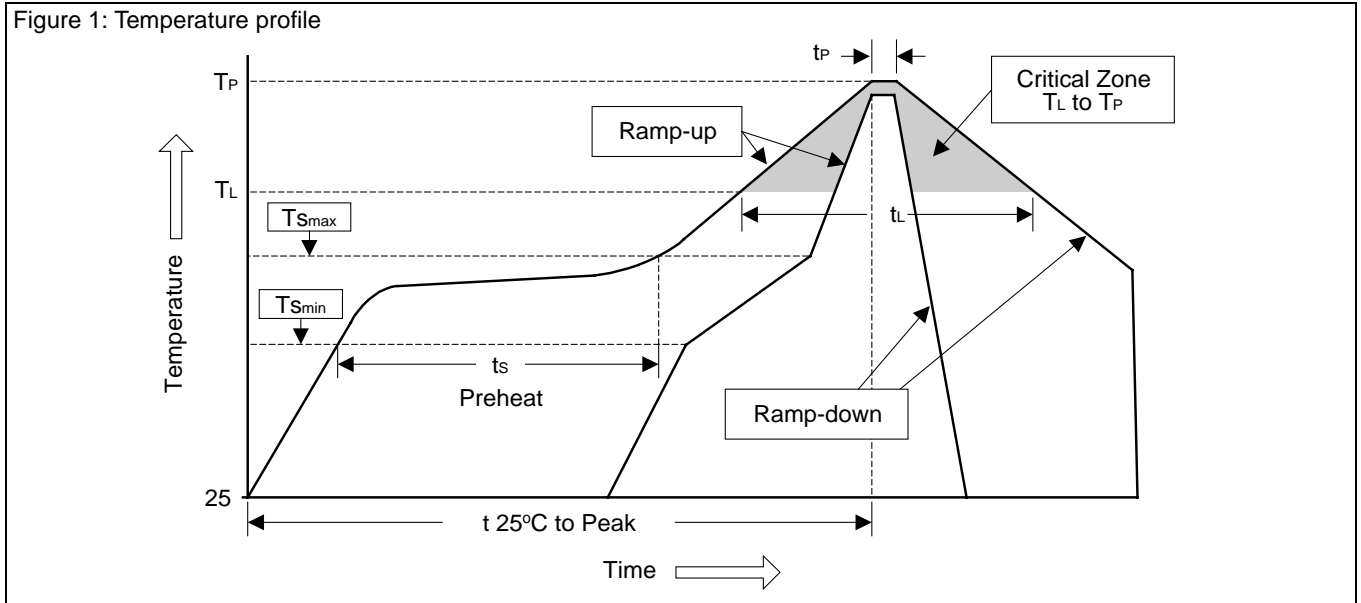
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Soldering Methods for HSMC's Products

1. Storage environment: Temperature=10°C~35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices

Figure 1: Temperature profile



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (T_{Smin})	100°C	150°C
- Temperature Max (T_{Smax})	150°C	200°C
- Time (min to max) (t_s)	60~120 sec	60~180 sec
T_{Smax} to T_L		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60~150 sec	60~150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_p)	10~30 sec	20~40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak temperature	Dipping time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec